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Thu, 23 Mar	11:55 — 13:30	TEST	Methodology of Science  Arshinov V.I.  V-403
Mon, 03 Apr	16:15 — 17:50	TEST	Professional Practice (Pre-graduation)  Barbashov V.M.  dep.3
Mon, 03 Apr	17:55 — 19:30	ATT	Elements of Fault-tolerant Devices  Stenin V.Y., Kessarinskiy L.N.  V-306
Thu, 06 Apr	09:00 — 12:00	ATT	Principles of Nuclear Electronics  Atkin E.V.  V-306
Fri, 07 Apr	18:00 — 22:00	ATT	Elect Information Measuring Systems  Karakozov A.B., Kondratenko S.V.  V-306
Thu, 13 Apr	09:00 — 13:00	EXAM	Principles of Nuclear Electronics  Atkin E.V.  V-306
Mon, 17 Apr	18:00 — 22:00	EXAM	Elements of Fault-tolerant Devices  Stenin V.Y.  V-306
Fri, 21 Apr	18:00 — 22:00	EXAM	Elect Information Measuring Systems  Kondratenko S.V., Karakozov A.B.  V-306